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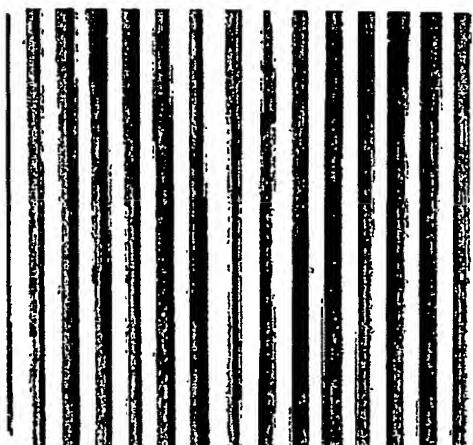
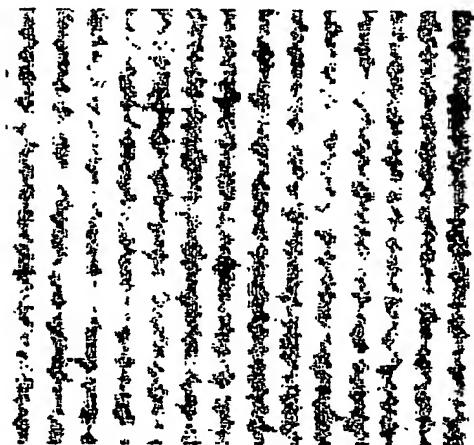
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[Continued on next page]

(54) Title: HOLOGRAPHIC DIFFRACTION GRATING, PROCESS FOR ITS PREPARATION AND ELECTRO-OPTICAL DEVICES INCLUDING THE SAME



(57) Abstract: Composite polymer/liquid crystal material having a holographic grating structure formed by an alternating ordered succession of crystal layers. The nematic liquid crystal monophase region which is substantially free from furthermore, the holographic grating structure is comprises the steps of: -heating a mixture of a photoinitiator, a monomer Composite polymer/liquid crystal material having a holographic grating structure of polymer layers and nematic liquid layers comprise an ordered nematic liquid crystal droplets, obtained by a process which above the nematic/isotropic phase separation -illumination of -ionization; -slow cooling of transition and a nematic liquid crystal and the temperature, in order to prevent isotropic/nematic phase transition of the liquid crystal; mixture at a rate lower than 0,3°C/mixture, to achieve a mixture with an interference pattern to induce polymerization the complete orientation of the liquid crystal director, and below the isotropic/nematic transition temperature.

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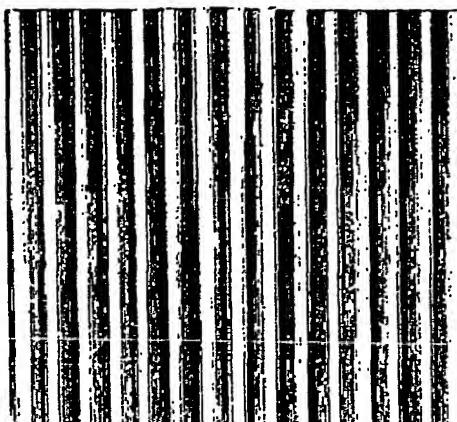
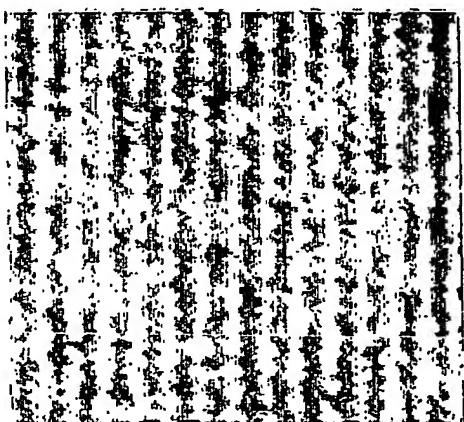
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